Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,316	HAYASHI ET AL.	
Examiner	Art Unit	
Anh T.N. Vo_	2861	

SEARCHED								
Class	Subclass	Date	Examiner					
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INTERFERENCE SEARCHED								
Class	Subclass	D	ate	Examiner				
347	86	7/14	2006	py				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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